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Application/Control	No.
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10/065,662 Examiner Applicant(s)/Patent under Reexamination

LIN, CHIH-CHUNG

Art Unit

John M. Villecco

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SEARCHED			
Class	Subclass	Date	Examiner
348	207.1 207.11 211.99 211.4 211.5	1/11/2007	٦٧
348	211.6	1/11/2007	JV
348	211.8	1/11/2007	JV
348	211.14	1/11/2007	JV
348	231.99	1/11/2007	٦٧
348	231.6	1/11/2007	JV
725	105	1/11/2007	JV
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INTERFERENCE SEARCHED			
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SEARCH NO (INCLUDING SEARCH)
	DATE	
EAST Search (see search history)	1/11/2007	.iV
348/552 (text search only)	1/11/2007	JV
250/208.1 (text search only)	1/11/2007	JV